

Search Notes

Application/Control No.

10/549,310

Examiner

Yevgeny Valenrod

Applicant(s)/Patent under
Reexamination

TAKANO ET AL.

Art Unit

1621

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN structure search for claim 11, see transcript	1/6/2007	YV
Inventor search. eDAN, EAST	1/6/2007	YV
EAST 560/303, 338, 360, 383 +text +inventor search, see transcript	1/6/2007	YV
STIC search, see transcript	12/29/2006	YV